

Notice of References Cited	Application/Control No. 10/626,407	Applicant(s)/Patent Under Reexamination TARABICHI, SAMIH	
	Examiner JEFFREY G. HOEKSTRA	Art Unit 3736	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,420,222 A	01-1969	NOE JOSEPH T; et. al.	600/595
*	B	US-3,722,100 A	03-1973	Weisman et al.	433/72
*	C	US-4,171,768 A	10-1979	Christiansson, Fingal	236/42
*	D	US-4,501,266 A	02-1985	McDaniel, John	606/90
*	E	US-4,687,384 A	08-1987	McCoy, David A.	408/10
*	F	US-5,213,112 A	05-1993	Niwa et al.	600/587
*	G	US-5,484,447	01-1996	Waldock et al.	606/107
*	H	US-5,701,370 A	12-1997	Muhs et al.	385/13
*	I	US-5,800,438 A	09-1998	Tuke et al.	606/90
*	J	US-6,361,506 B1	03-2002	Saenger et al.	600/587
*	K	US-6,716,043 B2	04-2004	Ishizuka, Shinichi	439/131
*	L	US-2004/0260208 A1	12-2004	Laprade et al.	600/595
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.